

UTC UNISONIC TECHNOLOGIES CO., LTD

6N65-CQ

Preliminary

6A, 650V N-CHANNEL **POWER MOSFET**

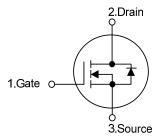
DESCRIPTION

The UTC 6N65-CQ is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)}$ < 1.4 Ω @ V_{GS} = 10 V, I_D = 2.0 A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

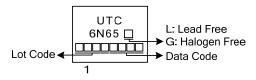


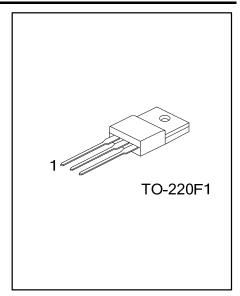
ORDERING INFORMATION

Ordering Number		Deekege	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N65L-TF1-T	6N65L-TF1-T 6N65G-TF1-T		G	D	S	Tube	
Note: Pin Assignment: G: Gate D: Drain S: Source							
6N65G-TF1-T		(1) T: Tube					

(1)Packing Type	
(2)Package Type	(2) TF1: TO-220F1
(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING





1 of 5

QW-R205-381.a

■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	V _{DSS}	650	V	
Gate-Source Voltage	V _{GSS}	±30	V	
Continuous Drain Current	I _D	6	А	
Pulsed Drain Current (Note 2)	I _{DM}	24	А	
Avalanche Energy Single Pulsed (Note 3)	E _{AS}	72	mJ	
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2.8	V/ns	
Power Dissipation	PD	40	W	
Junction Temperature	TJ	+150	°C	
Storage Temperature	T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 4.0mH, I_{AS} = 6.0A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

4. $I_{SD} \le 6.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ _{JA}	62.5	°C/W	
Junction to Case	θ」	3.2	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

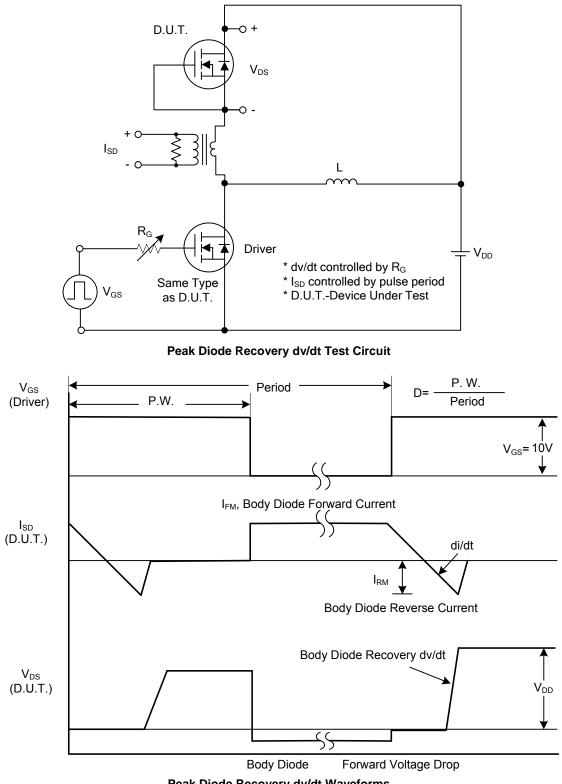
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250µA	650			V
Drain-Source Leakage Current	I _{DSS}	$V_{DS} = 650 V, V_{GS} = 0 V$			10	μA
Cate Source Leakage Current Forward	I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
Gate- Source Leakage Current Reverse		V_{GS} = -30V, V_{DS} = 0V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V_{DS} = V_{GS} , I_D = 250 μ A	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 3.0A			1.4	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	CISS			895		pF
Output Capacitance	C _{OSS}	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		126		pF
Reverse Transfer Capacitance	C _{RSS}			22		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_{G}	V _{DS} =50V, V _{GS} =10V, I _D =1.3A, I _D =100µA (Note 1, 2)		93		nC
Gate-Source Charge	Q_{GS}			8		nC
Gate-Drain Charge	Q_{GD}	$I_D = 100\mu A$ (Note 1, 2)		18		nC
Turn-On Delay Time (Note 1)	t _{D(ON)}			54		ns
Turn-On Rise Time	t _R	V _{DD} =30V, V _{GS} =10V, I _D =0.5A, R _G =25Ω (Note 1, 2)		102		ns
Turn-Off Delay Time	t _{D(OFF)}			276		ns
Turn-Off Fall Time	t _F			126		ns
DRAIN-SOURCE DIODE CHARACTERISTI	CS AND MA	XIMUM RATINGS				
Maximum Continuous Drain-Source Diode	I				6	^
Forward Current	Is				0	A
Maximum Pulsed Drain-Source Diode	1				24	А
Forward Current	I _{SM}				24	А
Drain-Source Diode Forward Voltage	V_{SD}	I _S =6.0A , V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time	t _{rr}	I _S =6.0A , V _{GS} =0V		310		ns
Body Diode Reverse Recovery Charge	Q _{rr}	di/dt=100A/µs		2.42		μC
Notes: 1 Pulse Test: Pulse width < 300us D	$u_{\rm tv} c_{\rm v} c_{\rm h} < 2$	%				

Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%

2. Essentially independent of operating temperature



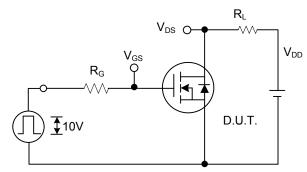
TEST CIRCUITS AND WAVEFORMS



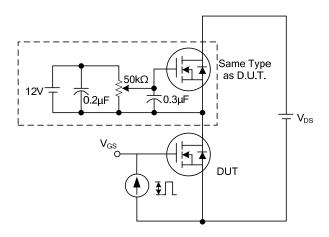
Peak Diode Recovery dv/dt Waveforms



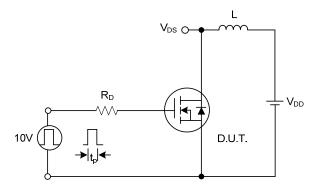
TEST CIRCUITS AND WAVEFORMS (Cont.)



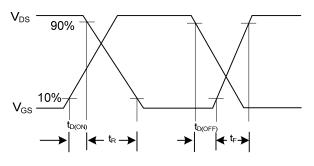
Switching Test Circuit



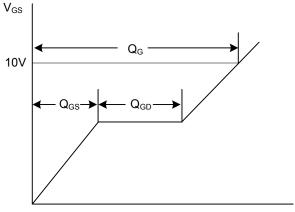
Gate Charge Test Circuit



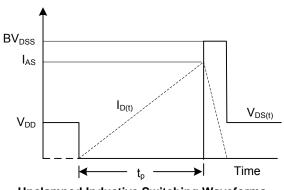
Unclamped Inductive Switching Test Circuit



Switching Waveforms



Charge Gate Charge Waveform



Unclamped Inductive Switching Waveforms



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